Application/Control No. Applicant(s)/Patent Under Reexamination 10/651,428 XIE, FEI **Notice of References Cited** Art Unit Examiner Page 1 of 1 Yuwen Pan 2618 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-6,718,298 04-2004 Α Judge, Rupinder 704/215 US-В US-С US-D US-Ε F US-US-G US-US-US-

FOREIGN PATENT DOCUMENTS

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